

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10549801	FUNAHASHI, MASAKAZU
Examiner	Art Unit	
Dawn Garrett	1786	

### SEARCHED

Class	Subclass	Date	Examiner
428	690, 917 (see EAST search printout for all listed - limited by keywords)	7-27-08	DG
313	504, 506	7-27-08	DG
257	E51.05, E51.051	7-27-08	DG
564	426, 434	7-27-08	DG
	see EAST search history	12/2010; 7/2011	DG

### SEARCH NOTES

Search Notes	Date	Examiner
EIC 1700 STIC structure search - see printout	7-22-08	DG
Inventor Name Search	7-27-08	DG
EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	7-27-08	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	4-2-2009 and 4-4-2009	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	8-19-2009 and 8-22-2009	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5-12-2010	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	12-16-2010	DG
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	7-27-2011	DG

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner